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# Understanding <u>Embedded - FPGAs (Field Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	832
Number of Logic Elements/Cells	8320
Total RAM Bits	106496
Number of I/O	-
Number of Gates	526000
Voltage - Supply	2.375V ~ 2.625V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	672-BBGA
Supplier Device Package	672-FBGA (27x27)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep20k200fc672-2

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Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

- Windows-based PCs, Sun SPARCstations, and HP 9000 Series 700/800 workstations
- Altera MegaCore® functions and Altera Megafunction Partners Program (AMPP<sup>SM</sup>) megafunctions
- NativeLink<sup>TM</sup> integration with popular synthesis, simulation, and timing analysis tools
- Quartus II SignalTap<sup>®</sup> embedded logic analyzer simplifies in-system design evaluation by giving access to internal nodes during device operation
- Supports popular revision-control software packages including PVCS, Revision Control System (RCS), and Source Code Control System (SCCS)

Device	144-Pin TQFP	208-Pin PQFP RQFP	240-Pin PQFP RQFP	356-Pin BGA	652-Pin BGA	655-Pin PGA
EP20K30E	92	125				
EP20K60E	92	148	151	196		
EP20K100	101	159	189	252		
EP20K100E	92	151	183	246		
EP20K160E	88	143	175	271		
EP20K200		144	174	277		
EP20K200E		136	168	271	376	
EP20K300E			152		408	
EP20K400					502	502
EP20K400E					488	
EP20K600E					488	
EP20K1000E					488	
EP20K1500E					488	

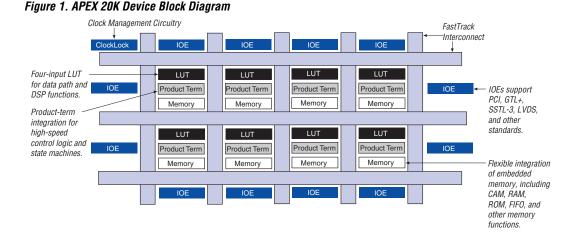
Feature	APEX 20K Devices	APEX 20KE Devices
MultiCore system integration	Full support	Full support
SignalTap logic analysis	Full support	Full support
32/64-Bit, 33-MHz PCI	Full compliance in -1, -2 speed grades	Full compliance in -1, -2 speed grades
32/64-Bit, 66-MHz PCI	-	Full compliance in -1 speed grade
MultiVolt I/O	2.5-V or 3.3-V V <sub>CCIO</sub> V <sub>CCIO</sub> selected for device Certain devices are 5.0-V tolerant	1.8-V, 2.5-V, or 3.3-V V <sub>CCIO</sub> V <sub>CCIO</sub> selected block-by-block 5.0-V tolerant with use of external resistor
ClockLock support	Clock delay reduction 2× and 4× clock multiplication	Clock delay reduction $m/(n \times v)$ or $m/(n \times k)$ clock multiplication Drive ClockLock output off-chip External clock feedback ClockShift LVDS support Up to four PLLs ClockShift, clock phase adjustment
Dedicated clock and input pins	Six	Eight
I/O standard support	2.5-V, 3.3-V, 5.0-V I/O 3.3-V PCI Low-voltage complementary metal-oxide semiconductor (LVCMOS) Low-voltage transistor-to-transistor logic (LVTTL)	1.8-V, 2.5-V, 3.3-V, 5.0-V I/O 2.5-V I/O 3.3-V PCI and PCI-X 3.3-V Advanced Graphics Port (AGP) Center tap terminated (CTT) GTL+ LVCMOS LVTTL True-LVDS and LVPECL data pins (in EP20K300E and larger devices) LVDS and LVPECL signaling (in all BGA and FineLine BGA devices) LVDS and LVPECL data pins up to 156 Mbps (in -1 speed grade devices) HSTL Class I PCI-X SSTL-2 Class I and II SSTL-3 Class I and II
Memory support	Dual-port RAM FIFO RAM ROM	CAM Dual-port RAM FIFO RAM ROM

# Functional Description

APEX 20K devices incorporate LUT-based logic, product-term-based logic, and memory into one device. Signal interconnections within APEX 20K devices (as well as to and from device pins) are provided by the FastTrack<sup>®</sup> Interconnect—a series of fast, continuous row and column channels that run the entire length and width of the device.

Each I/O pin is fed by an I/O element (IOE) located at the end of each row and column of the FastTrack Interconnect. Each IOE contains a bidirectional I/O buffer and a register that can be used as either an input or output register to feed input, output, or bidirectional signals. When used with a dedicated clock pin, these registers provide exceptional performance. IOEs provide a variety of features, such as 3.3-V, 64-bit, 66-MHz PCI compliance; JTAG BST support; slew-rate control; and tri-state buffers. APEX 20KE devices offer enhanced I/O support, including support for 1.8-V I/O, 2.5-V I/O, LVCMOS, LVTTL, LVPECL, 3.3-V PCI, PCI-X, LVDS, GTL+, SSTL-2, SSTL-3, HSTL, CTT, and 3.3-V AGP I/O standards.

The ESB can implement a variety of memory functions, including CAM, RAM, dual-port RAM, ROM, and FIFO functions. Embedding the memory directly into the die improves performance and reduces die area compared to distributed-RAM implementations. Moreover, the abundance of cascadable ESBs ensures that the APEX 20K device can implement multiple wide memory blocks for high-density designs. The ESB's high speed ensures it can implement small memory blocks without any speed penalty. The abundance of ESBs ensures that designers can create as many different-sized memory blocks as the system requires. Figure 1 shows an overview of the APEX 20K device.



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#### LE Operating Modes

The APEX 20K LE can operate in one of the following three modes:

- Normal mode
- Arithmetic mode
- Counter mode

Each mode uses LE resources differently. In each mode, seven available inputs to the LE—the four data inputs from the LAB local interconnect, the feedback from the programmable register, and the carry-in and cascade-in from the previous LE—are directed to different destinations to implement the desired logic function. LAB-wide signals provide clock, asynchronous clear, asynchronous preset, asynchronous load, synchronous clear, synchronous load, and clock enable control for the register. These LAB-wide signals are available in all LE modes.

The Quartus II software, in conjunction with parameterized functions such as LPM and DesignWare functions, automatically chooses the appropriate mode for common functions such as counters, adders, and multipliers. If required, the designer can also create special-purpose functions that specify which LE operating mode to use for optimal performance. Figure 8 shows the LE operating modes.

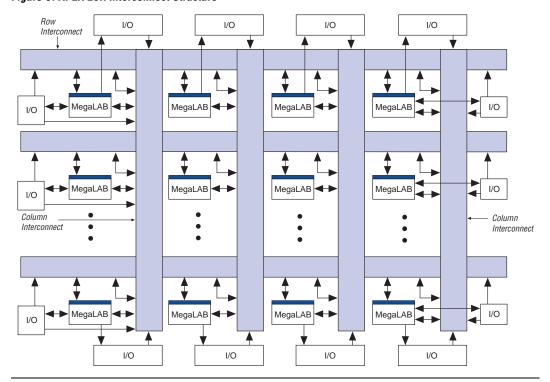


Figure 9. APEX 20K Interconnect Structure

A row line can be driven directly by LEs, IOEs, or ESBs in that row. Further, a column line can drive a row line, allowing an LE, IOE, or ESB to drive elements in a different row via the column and row interconnect. The row interconnect drives the MegaLAB interconnect to drive LEs, IOEs, or ESBs in a particular MegaLAB structure.

A column line can be directly driven by LEs, IOEs, or ESBs in that column. A column line on a device's left or right edge can also be driven by row IOEs. The column line is used to route signals from one row to another. A column line can drive a row line; it can also drive the MegaLAB interconnect directly, allowing faster connections between rows.

Figure 10 shows how the FastTrack Interconnect uses the local interconnect to drive LEs within MegaLAB structures.

Select Vertical I/O Pins IOE IOE FastRow Interconnect IOE IOE Drive Local Interconnect FastRow Drives Local Interconnect and FastRow Interconnect in Two MegaLAB Structures Interconnect Local Interconnect LEs MegaLAB MegaLAB *LABs* 

Figure 12. APEX 20KE FastRow Interconnect

Table 9 summarizes how various elements of the APEX 20K architecture drive each other.

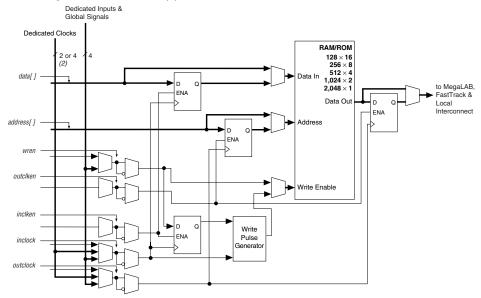


Figure 22. ESB in Single-Port Mode Note (1)

Notes to Figure 22:

- (1) All registers can be asynchronously cleared by ESB local interconnect signals, global signals, or the chip-wide reset.
- (2) APEX 20KE devices have four dedicated clocks.

### **Content-Addressable Memory**

In APEX 20KE devices, the ESB can implement CAM. CAM can be thought of as the inverse of RAM. When read, RAM outputs the data for a given address. Conversely, CAM outputs an address for a given data word. For example, if the data FA12 is stored in address 14, the CAM outputs 14 when FA12 is driven into it.

CAM is used for high-speed search operations. When searching for data within a RAM block, the search is performed serially. Thus, finding a particular data word can take many cycles. CAM searches all addresses in parallel and outputs the address storing a particular word. When a match is found, a match flag is set high. Figure 23 shows the CAM block diagram.



For more information on APEX 20KE devices and CAM, see *Application Note 119 (Implementing High-Speed Search Applications with APEX CAM).* 

### **Driving Signals to the ESB**

ESBs provide flexible options for driving control signals. Different clocks can be used for the ESB inputs and outputs. Registers can be inserted independently on the data input, data output, read address, write address, WE, and RE signals. The global signals and the local interconnect can drive the WE and RE signals. The global signals, dedicated clock pins, and local interconnect can drive the ESB clock signals. Because the LEs drive the local interconnect, the LEs can control the WE and RE signals and the ESB clock, clock enable, and asynchronous clear signals. Figure 24 shows the ESB control signal generation logic.

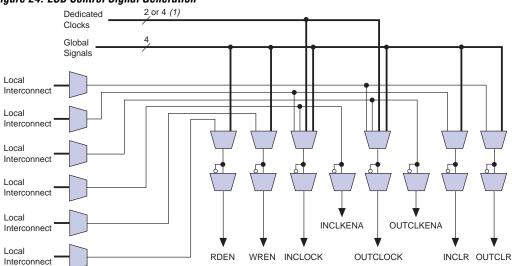


Figure 24. ESB Control Signal Generation

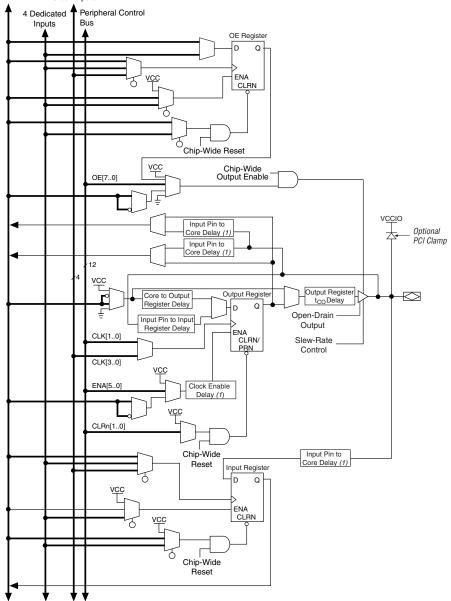
Note to Figure 24:

(1) APEX 20KE devices have four dedicated clocks.

An ESB is fed by the local interconnect, which is driven by adjacent LEs (for high-speed connection to the ESB) or the MegaLAB interconnect. The ESB can drive the local, MegaLAB, or FastTrack Interconnect routing structure to drive LEs and IOEs in the same MegaLAB structure or anywhere in the device.

Figure 26. APEX 20KE Bidirectional I/O Registers Notes (1), (2)

Row, Column, FastRow, 4 Dedicated or Local Interconnect Clock Inputs



Notes to Figure 26:

- (1) This programmable delay has four settings: off and three levels of delay.
- (2) The output enable and input registers are LE registers in the LAB adjacent to the bidirectional pin.

Table 15. APEX 20K ClockLock & ClockBoost Parameters for -1 Speed-Grade Devices (Part 2 of 2)								
Symbol	Parameter	Min	Max	Unit				
t <sub>SKEW</sub>	Skew delay between related ClockLock/ClockBoost-generated clocks		500	ps				
t <sub>JITTER</sub>	Jitter on ClockLock/ClockBoost-generated clock (5)		200	ps				
t <sub>INCLKSTB</sub>	Input clock stability (measured between adjacent clocks)		50	ps				

#### Notes to Table 15:

- (1) The PLL input frequency range for the EP20K100-1X device for 1x multiplication is 25 MHz to 175 MHz.
- (2) All input clock specifications must be met. The PLL may not lock onto an incoming clock if the clock specifications are not met, creating an erroneous clock within the device.
- (3) During device configuration, the ClockLock and ClockBoost circuitry is configured first. If the incoming clock is supplied during configuration, the ClockLock and ClockBoost circuitry locks during configuration, because the lock time is less than the configuration time.
- (4) The jitter specification is measured under long-term observation.
- (5) If the input clock stability is 100 ps,  $t_{JITTER}$  is 250 ps.

Table 16 summarizes the APEX 20K ClockLock and ClockBoost parameters for -2 speed grade devices.

Symbol	Parameter	Min	Max	Unit	
f <sub>OUT</sub>	Output frequency	25	170	MHz	
f <sub>CLK1</sub>	Input clock frequency (ClockBoost clock multiplication factor equals 1)	25	170	MHz	
f <sub>CLK2</sub>	Input clock frequency (ClockBoost clock multiplication factor equals 2)	16	80	MHz	
f <sub>CLK4</sub>	Input clock frequency (ClockBoost clock multiplication factor equals 4)	10	34	MHz	
t <sub>OUTDUTY</sub>	Duty cycle for ClockLock/ClockBoost-generated clock	40	60	%	
f <sub>CLKDEV</sub>	Input deviation from user specification in the Quartus II software (ClockBoost clock multiplication factor equals one) (1)		25,000 (2)	PPM	
t <sub>R</sub>	Input rise time		5	ns	
t <sub>F</sub>	Input fall time		5	ns	
t <sub>LOCK</sub>	Time required for ClockLock/ ClockBoost to acquire lock (3)		10	μѕ	
t <sub>SKEW</sub>	Skew delay between related ClockLock/ ClockBoost-generated clock	500	500	ps	
t <sub>JITTER</sub>	Jitter on ClockLock/ ClockBoost-generated clock (4)		200	ps	
t <sub>INCLKSTB</sub>	Input clock stability (measured between adjacent clocks)		50	ps	

#### Notes to Table 16:

- (1) To implement the ClockLock and ClockBoost circuitry with the Quartus II software, designers must specify the input frequency. The Quartus II software tunes the PLL in the ClockLock and ClockBoost circuitry to this frequency. The f<sub>CLKDEV</sub> parameter specifies how much the incoming clock can differ from the specified frequency during device operation. Simulation does not reflect this parameter.
- (2) Twenty-five thousand parts per million (PPM) equates to 2.5% of input clock period.
- (3) During device configuration, the ClockLock and ClockBoost circuitry is configured before the rest of the device. If the incoming clock is supplied during configuration, the ClockLock and ClockBoost circuitry locks during configuration because the  $t_{LOCK}$  value is less than the time required for configuration.
- (4) The  $t_{IITTER}$  specification is measured under long-term observation.

Tables 17 and 18 summarize the ClockLock and ClockBoost parameters for APEX 20KE devices.

Table 17. AP	PEX 20KE ClockLock & ClockBoost	Parameters /	Vote (1)			
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t <sub>R</sub>	Input rise time				5	ns
t <sub>F</sub>	Input fall time				5	ns
t <sub>INDUTY</sub>	Input duty cycle		40		60	%
t <sub>INJITTER</sub>	Input jitter peak-to-peak				2% of input period	peak-to- peak
t <sub>OUTJITTER</sub>	Jitter on ClockLock or ClockBoost- generated clock				0.35% of output period	RMS
t <sub>OUTDUTY</sub>	Duty cycle for ClockLock or ClockBoost-generated clock		45		55	%
t <sub>LOCK</sub> (2), (3)	Time required for ClockLock or ClockBoost to acquire lock				40	μs

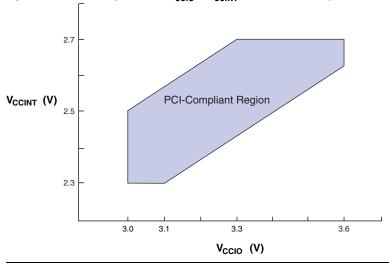


Figure 33. Relationship between  $V_{CCIO}$  &  $V_{CCINT}$  for 3.3-V PCI Compliance

Figure 34 shows the typical output drive characteristics of APEX 20K devices with 3.3-V and 2.5-V  $V_{\rm CCIO}$ . The output driver is compatible with the 3.3-V *PCI Local Bus Specification, Revision 2.2* (when VCCIO pins are connected to 3.3 V). 5-V tolerant APEX 20K devices in the -1 speed grade are 5-V PCI compliant over all operating conditions.

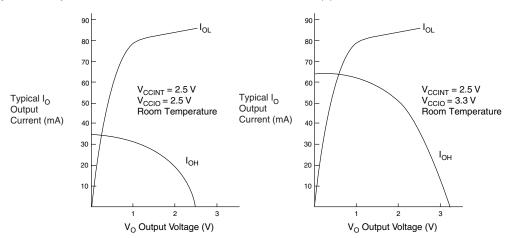


Figure 34. Output Drive Characteristics of APEX 20K Device Note (1)

Note to Figure 34:

(1) These are transient (AC) currents.

Table 31. APEX 2	Table 31. APEX 20K f <sub>MAX</sub> Timing Parameters (Part 2 of 2)						
Symbol	Parameter						
t <sub>ESBDATACO2</sub>	ESB clock-to-output delay without output registers						
t <sub>ESBDD</sub>	ESB data-in to data-out delay for RAM mode						
t <sub>PD</sub>	ESB macrocell input to non-registered output						
t <sub>PTERMSU</sub>	ESB macrocell register setup time before clock						
t <sub>PTERMCO</sub>	ESB macrocell register clock-to-output delay						
t <sub>F1-4</sub>	Fanout delay using local interconnect						
t <sub>F5-20</sub>	Fanout delay using MegaLab Interconnect						
t <sub>F20+</sub>	Fanout delay using FastTrack Interconnect						
t <sub>CH</sub>	Minimum clock high time from clock pin						
t <sub>CL</sub>	Minimum clock low time from clock pin						
t <sub>CLRP</sub>	LE clear pulse width						
t <sub>PREP</sub>	LE preset pulse width						
t <sub>ESBCH</sub>	Clock high time						
t <sub>ESBCL</sub>	Clock low time						
t <sub>ESBWP</sub>	Write pulse width						
t <sub>ESBRP</sub>	Read pulse width						

Tables 32 and 33 describe APEX 20K external timing parameters.

Table 32. APEX 20K External Timing Parameters Note (1)				
Symbol	Clock Parameter			
t <sub>INSU</sub>	Setup time with global clock at IOE register			
t <sub>INH</sub>	Hold time with global clock at IOE register			
t <sub>OUTCO</sub>	Clock-to-output delay with global clock at IOE register			

Table 33. APEX 20K External Bidirectional Timing Parameters Note (1)							
Symbol	Parameter	Conditions					
t <sub>INSUBIDIR</sub>	Setup time for bidirectional pins with global clock at same-row or same-column LE register						
t <sub>INHBIDIR</sub>	Hold time for bidirectional pins with global clock at same-row or same-column LE register						
<sup>t</sup> OUTCOBIDIR	Clock-to-output delay for bidirectional pins with global clock at IOE register	C1 = 10 pF					
t <sub>XZBIDIR</sub>	Synchronous IOE output buffer disable delay	C1 = 10 pF					
t <sub>ZXBIDIR</sub>	Synchronous IOE output buffer enable delay, slow slew rate = off	C1 = 10 pF					

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Units	
	Min	Max	Min	Max	Min	Max		
t <sub>SU</sub>	0.1		0.3		0.6		ns	
t <sub>H</sub>	0.5		0.8		0.9		ns	
t <sub>CO</sub>		0.1		0.4		0.6	ns	
t <sub>LUT</sub>		1.0		1.2		1.4	ns	
t <sub>ESBRC</sub>		1.7		2.1		2.4	ns	
t <sub>ESBWC</sub>		5.7		6.9		8.1	ns	
t <sub>ESBWESU</sub>	3.3		3.9		4.6		ns	
t <sub>ESBDATASU</sub>	2.2		2.7		3.1		ns	
t <sub>ESBDATAH</sub>	0.6		0.8		0.9		ns	
t <sub>ESBADDRSU</sub>	2.4		2.9		3.3		ns	
t <sub>ESBDATACO1</sub>		1.3		1.6		1.8	ns	
t <sub>ESBDATACO2</sub>		2.5		3.1		3.6	ns	
t <sub>ESBDD</sub>		2.5		3.3		3.6	ns	
t <sub>PD</sub>		2.5		3.1		3.6	ns	
t <sub>PTERMSU</sub>	1.7		2.1		2.4		ns	
t <sub>PTERMCO</sub>		1.0		1.2		1.4	ns	
t <sub>F1-4</sub>		0.4		0.5		0.6	ns	
t <sub>F5-20</sub>		2.6		2.8		2.9	ns	
t <sub>F20+</sub>		3.7		3.8		3.9	ns	
t <sub>CH</sub>	2.0		2.5		3.0		ns	
t <sub>CL</sub>	2.0		2.5		3.0		ns	
t <sub>CLRP</sub>	0.5		0.6		0.8		ns	
t <sub>PREP</sub>	0.5		0.5		0.5		ns	
t <sub>ESBCH</sub>	2.0		2.5		3.0		ns	
t <sub>ESBCL</sub>	2.0		2.5		3.0		ns	
t <sub>ESBWP</sub>	1.5		1.9		2.2		ns	
t <sub>ESBRP</sub>	1.0		1.2		1.4		ns	

Tables 43 through 48 show the I/O external and external bidirectional timing parameter values for EP20K100, EP20K200, and EP20K400 APEX 20K devices.

Symbol	-1			-2		-3	
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.83		2.57		3.79	ns
t <sub>ESBSRC</sub>		2.46		3.26		4.61	ns
t <sub>ESBAWC</sub>		3.50		4.90		7.23	ns
t <sub>ESBSWC</sub>		3.77		4.90		6.79	ns
t <sub>ESBWASU</sub>	1.59		2.23		3.29		ns
t <sub>ESBWAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWDSU</sub>	1.75		2.46		3.62		ns
t <sub>ESBWDH</sub>	0.00		0.00		0.00		ns
t <sub>ESBRASU</sub>	1.76		2.47		3.64		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWESU</sub>	1.68		2.49		3.87		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	0.08		0.43		1.04		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.29		0.72		1.46		ns
t <sub>ESBRADDRSU</sub>	0.36		0.81		1.58		ns
t <sub>ESBDATACO1</sub>		1.06		1.24		1.55	ns
t <sub>ESBDATACO2</sub>		2.39		3.35		4.94	ns
t <sub>ESBDD</sub>		3.50		4.90		7.23	ns
t <sub>PD</sub>		1.72		2.41		3.56	ns
t <sub>PTERMSU</sub>	0.99		1.56		2.55		ns
t <sub>PTERMCO</sub>		1.07		1.26		1.08	ns

Table 62. EP20K	I GOL IMAX LOL	, iming mid	1		Ī		1
Symbol	-	1		-2		3	Unit
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.61		1.84		1.97	ns
t <sub>ESBSRC</sub>		2.57		2.97		3.20	ns
t <sub>ESBAWC</sub>		0.52		4.09		4.39	ns
t <sub>ESBSWC</sub>		3.17		3.78		4.09	ns
t <sub>ESBWASU</sub>	0.56		6.41		0.63		ns
t <sub>ESBWAH</sub>	0.48		0.54		0.55		ns
t <sub>ESBWDSU</sub>	0.71		0.80		0.81		ns
t <sub>ESBWDH</sub>	.048		0.54		0.55		ns
t <sub>ESBRASU</sub>	1.57		1.75		1.87		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.20		ns
t <sub>ESBWESU</sub>	1.54		1.72		1.80		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	-0.16		-0.20		-0.20		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.12		0.08		0.13		ns
t <sub>ESBRADDRSU</sub>	0.17		0.15		0.19		ns
t <sub>ESBDATACO1</sub>		1.20		1.39		1.52	ns
t <sub>ESBDATACO2</sub>		2.54		2.99		3.22	ns
t <sub>ESBDD</sub>		3.06		3.56		3.85	ns
t <sub>PD</sub>		1.73		2.02		2.20	ns
t <sub>PTERMSU</sub>	1.11		1.26		1.38		ns
t <sub>PTERMCO</sub>		1.19		1.40		1.08	ns

Table 63. EP20K100E f <sub>MAX</sub> Routing Delays											
Symbol	-	1	-	-2 -3			Unit				
	Min	Max	Min	Max	Min	Max					
t <sub>F1-4</sub>		0.24		0.27		0.29	ns				
t <sub>F5-20</sub>		1.04		1.26		1.52	ns				
t <sub>F20+</sub>		1.12		1.36		1.86	ns				

Table 69. EP20K160E f <sub>MAX</sub> Routing Delays											
Symbol	-	1		-2	-3		Unit				
	Min	Max	Min	Max	Min	Max					
t <sub>F1-4</sub>		0.25		0.26		0.28	ns				
t <sub>F5-20</sub>		1.00		1.18		1.35	ns				
t <sub>F20+</sub>		1.95		2.19		2.30	ns				

Symbol	-	-1		-2		-3		
	Min	Max	Min	Max	Min	Max	1	
t <sub>CH</sub>	1.34		1.43		1.55		ns	
t <sub>CL</sub>	1.34		1.43		1.55		ns	
t <sub>CLRP</sub>	0.18		0.19		0.21		ns	
t <sub>PREP</sub>	0.18		0.19		0.21		ns	
t <sub>ESBCH</sub>	1.34		1.43		1.55		ns	
t <sub>ESBCL</sub>	1.34		1.43		1.55		ns	
t <sub>ESBWP</sub>	1.15		1.45		1.73		ns	
t <sub>ESBRP</sub>	0.93		1.15		1.38		ns	

Symbol	-1		-2		-3	Unit	
	Min	Max	Min	Max	Min	Max	
t <sub>INSU</sub>	2.23		2.34		2.47		ns
t <sub>INH</sub>	0.00		0.00		0.00		ns
t <sub>OUTCO</sub>	2.00	5.07	2.00	5.59	2.00	6.13	ns
t <sub>INSUPLL</sub>	2.12		2.07		=		ns
t <sub>INHPLL</sub>	0.00		0.00		=		ns
toutcople	0.50	3.00	0.50	3.35	-	-	ns

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Spee	Unit	
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.67		1.91		1.99	ns
t <sub>ESBSRC</sub>		2.30		2.66		2.93	ns
t <sub>ESBAWC</sub>		3.09		3.58		3.99	ns
t <sub>ESBSWC</sub>		3.01		3.65		4.05	ns
t <sub>ESBWASU</sub>	0.54		0.63		0.65		ns
t <sub>ESBWAH</sub>	0.36		0.43		0.42		ns
t <sub>ESBWDSU</sub>	0.69		0.77		0.84		ns
t <sub>ESBWDH</sub>	0.36		0.43		0.42		ns
t <sub>ESBRASU</sub>	1.61		1.77		1.86		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.01		ns
t <sub>ESBWESU</sub>	1.35		1.47		1.61		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	-0.18		-0.30		-0.27		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	-0.02		-0.11		-0.03		ns
t <sub>ESBRADDRSU</sub>	0.06		-0.01		-0.05		ns
t <sub>ESBDATACO1</sub>		1.16		1.40		1.54	ns
t <sub>ESBDATACO2</sub>		2.18		2.55		2.85	ns
t <sub>ESBDD</sub>		2.73		3.17		3.58	ns
t <sub>PD</sub>		1.57		1.83		2.07	ns
t <sub>PTERMSU</sub>	0.92		0.99		1.18		ns
t <sub>PTERMCO</sub>		1.18		1.43		1.17	ns

Symbol	-1 Speed Grade		-2 Spee	d Grade	-3 Spee	Unit	
	Min	Max	Min	Max	Min	Max	
t <sub>INSUBIDIR</sub>	3.47		3.68		3.99		ns
t <sub>INHBIDIR</sub>	0.00		0.00		0.00		ns
toutcobidir	2.00	6.18	2.00	6.81	2.00	7.36	ns
t <sub>XZBIDIR</sub>		6.91		7.62		8.38	ns
t <sub>ZXBIDIR</sub>		6.91		7.62		8.38	ns
t <sub>INSUBIDIRPLL</sub>	3.05		3.26				ns
t <sub>INHBIDIRPLL</sub>	0.00		0.00				ns
toutcobidirpll	0.50	2.67	0.50	2.99			ns
<sup>t</sup> xzbidirpll		3.41		3.80			ns
tzxbidirpll		3.41		3.80			ns

Tables 109 and 110 show selectable I/O standard input and output delays for APEX 20KE devices. If you select an I/O standard input or output delay other than LVCMOS, add or subtract the selected speed grade to or from the LVCMOS value.

Table 109. Selectable I/O Standard Input Delays								
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit	
	Min	Max	Min	Max	Min	Max	Min	
LVCMOS		0.00		0.00		0.00	ns	
LVTTL		0.00		0.00		0.00	ns	
2.5 V		0.00		0.04		0.05	ns	
1.8 V		-0.11		0.03		0.04	ns	
PCI		0.01		0.09		0.10	ns	
GTL+		-0.24		-0.23		-0.19	ns	
SSTL-3 Class I		-0.32		-0.21		-0.47	ns	
SSTL-3 Class II		-0.08		0.03		-0.23	ns	
SSTL-2 Class I		-0.17		-0.06		-0.32	ns	
SSTL-2 Class II		-0.16		-0.05		-0.31	ns	
LVDS		-0.12		-0.12		-0.12	ns	
CTT		0.00		0.00		0.00	ns	
AGP		0.00		0.00		0.00	ns	

Table 110. Selectab	le I/O Standa	ard Output De	lays					
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit	
	Min	Max	Min	Max	Min	Max	Min	
LVCMOS		0.00		0.00		0.00	ns	
LVTTL		0.00		0.00		0.00	ns	
2.5 V		0.00		0.09		0.10	ns	
1.8 V		2.49		2.98		3.03	ns	
PCI		-0.03		0.17		0.16	ns	
GTL+		0.75		0.75		0.76	ns	
SSTL-3 Class I		1.39		1.51		1.50	ns	
SSTL-3 Class II		1.11		1.23		1.23	ns	
SSTL-2 Class I		1.35		1.48		1.47	ns	
SSTL-2 Class II		1.00		1.12		1.12	ns	
LVDS		-0.48		-0.48		-0.48	ns	
CTT		0.00		0.00		0.00	ns	
AGP		0.00		0.00		0.00	ns	

# Power Consumption

To estimate device power consumption, use the interactive power calculator on the Altera web site at http://www.altera.com.

# Configuration & Operation

The APEX 20K architecture supports several configuration schemes. This section summarizes the device operating modes and available device configuration schemes.

## **Operating Modes**

The APEX architecture uses SRAM configuration elements that require configuration data to be loaded each time the circuit powers up. The process of physically loading the SRAM data into the device is called configuration. During initialization, which occurs immediately after configuration, the device resets registers, enables I/O pins, and begins to operate as a logic device. The I/O pins are tri-stated during power-up, and before and during configuration. Together, the configuration and initialization processes are called *command mode*; normal device operation is called *user mode*.

Before and during device configuration, all I/O pins are pulled to  $V_{\mbox{\scriptsize CCIO}}$  by a built-in weak pull-up resistor.